

PCTEST

7185 Oakland Mills Road, Columbia, MD 21046 USA Tel. 410.290.6652 / Fax 410.290.6654 http://www.pctest.com



HEARING AID COMPATIBILITY

Applicant Name:

Samsung Electronics Co., Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 16677, Korea Date of Testing: 02/08/2021 - 02/12/2021 Test Site/Location: PCTEST, Columbia, MD, USA Test Report Serial No.: 1M2012210203-05-R1.A3L Date of Issue: 02/15/2021

FCC ID: A3LSMG998U

APPLICANT: SAMSUNG ELECTRONICS CO., LTD.

Scope of Test: Audio Band Magnetic Testing (T-Coil)

Application Type: Class II Permissive Change

FCC Rule Part(s): CFR §20.19(b)
HAC Standard: ANSI C63.19-2011

285076 D01 HAC Guidance v05

285076 D02 T-Coil testing for CMRS IP v03

DUT Type: Portable Handset Model: SM-G998U Additional Model(s): SM-G998U1

Test Device Serial No.: Pre-Production Sample [S/N: 3972S]

Class II Permissive Change(s): See FCC Change Document

C63.19-2011 HAC Category: T4 (SIGNAL TO NOISE CATEGORY, NR n77 Only)

Note: This revised Test Report (S/N: 1M2012210203-05-R1.A3L) supersedes and replaces the previously issued test report on the same subject device for the same type of testing as indicated. Please discard or destroy the previously issued test report(s) and dispose of it accordingly.

This report and category pertains only to NR n77 supported by this wireless portable device. The overall category rating of the device is determined by the lowest rating obtained over all air interfaces supported by the device. This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Test results reported herein relate only to the item(s) tested. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. North American Bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.







FCC ID: A3LSMG998U	PCTEST* Proud to be pert of the decreased	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 1 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		raye 1 01 42

TABLE OF CONTENTS

1.	INTRODUCTION	3
2.	DUT DESCRIPTION	4
3.	ANSI C63.19-2011 PERFORMANCE CATEGORIES	6
4.	METHOD OF MEASUREMENT	8
5.	OTT VOIP TEST SYSTEM AND DUT CONFIGURATION	17
6.	T-COIL TEST SUMMARY	19
7.	MEASUREMENT UNCERTAINTY	23
8.	EQUIPMENT LIST	24
9.	TEST DATA	25
10.	CALIBRATION CERTIFICATES	30
11.	CONCLUSION	37
12.	REFERENCES	38
13.	TEST SETUP PHOTOGRAPHS	40

FCC ID: A3LSMG998U	PCTEST* Proud to be pert of the decreased	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 2 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		raye 2 01 42

1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide and 30 million people in the United States suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid in-vitu

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

FCC ID: A3LSMG998U	PCTEST Proud to be port of ® simulation	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 3 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 3 01 42

DUT DESCRIPTION 2.



FCC ID: A3LSMG998U

Applicant: Samsung Electronics Co., Ltd.

129, Samsung-ro, Maetan dong,

Yeongtong-gu, Suwon-si Gyeonggi-do 16677, Korea

Model: SM-G998U Additional Model(s): SM-G998U1

Serial Number: 3972S HW Version: REV1.0

SW Version: G998USQU1ATLU Antenna: Internal Antenna DUT Type: Portable Handset

FCC ID: A3LSMG998U	PCTEST *	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dog 4 of 40
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 4 of 42

Table 2-1 A3LSMG998U HAC Air Interfaces

			AJL	SIVIG9900 FIAC All IIILEHA	1	
Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service	Audio Codec Evaluated
	835		3			
CDMA	1900	VO	No ³	Yes: WIFI or BT	CMRS Voice	EVRC
	EvDO	VD	No ³	Yes: WIFI or BT	Google Duo ¹	OPUS
	850	1/0	3	V 1455 DT		550
GSM	1900	VO	No ³	Yes: WIFI or BT	CMRS Voice	EFR
	GPRS/EDGE	VD	No ³	Yes: WIFI or BT	Google Duo ¹	OPUS
	850					
UMTS	1700	VD	No ³	Yes: WIFI or BT	CMRS Voice	NB AMR
OIVITS	1900					
	HSPA	VD	No ³	Yes: WIFI or BT	Google Duo ¹	OPUS
	680 (B71)					
	700 (B12)					
	780 (B13)					
	790 (B14)					
	850 (B5)					
LTE (FDD)	850 (B26)	VD	No ³	Yes: WIFI or BT	VoLTE, Google Duo ¹	Volte: NB AMR, WB AMR, EVS
LIE (FDD)	1700 (B4)	V V	INO	res. WIFI OF BT	VOLTE, GOOGIE DUO	Google Duo: OPUS
	1700 (B66)					
	1900 (B2)					
	1900 (B25)					
	2300 (B30)					
	2500 (B7)					
	2600 (B38)					
LTE (TDD)	2600 (B41)	VD	No ³	Yes: WIFI or BT	VoLTE, Google Duo ¹	VoLTE: NB AMR, WB AMR, EVS Google Duo: OPUS
	3600 (B48)					Google Buo. of 65
	680 (n71)					
	700 (n12)					
	850 (n5)					
NR (FDD)	1700 (n66)	VD	No ³	Yes: WIFI or BT	Google Duo ¹	OPUS
	1900 (n2)					
	1900 (n25)					
	2300 (n30)					
	2600 (n41)		No ³			
NR (TDD)	3800 (n77)	VD	Yes ²	Yes: WIFI or BT	Google Duo ¹	OPUS
Wit (100)	28000 (n261)	, ,,,	No ³	res. will of B1	Google Duo	0.03
	39000 (n260)		140			
	2450					
	5200 (U-NII 1)					
	5300 (U-NII 2A)					
	5500 (U-NII 2C)					VoWIFI: NB AMR, WB AMR, EVS
WIFI	5800 (U-NII 3)	VD	No ³	Yes: CDMA, GSM, UMTS, LTE, or NR	VoWIFI, Google Duo ¹	Google Duo: OPUS
	6175 (U-NII 5)					
	6475 (U-NII 6)					
	6700 (U-NII 7)					
	7000 (U-NII 8)					
BT	2450	DT	No	Yes: CDMA, GSM, UMTS, LTE, or NR	N/A	N/A
Type Transport VO = Voice Onl DT = Digital Da						
	/D = CMRS and/or IP Voice over Data Transport 3. This report pertains only to NR n77. For full data, please refer to the Original Certification Test Report (T-Coil Report S/N:					

3. This report pertains only to NR n77. For full data, please refer to the Original Certification Test Report (T-Coil Report S/N: 1M2009230152-21-R2.A3L)

FCC ID: A3LSMG998U	PCTEST	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogg F of 40
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 5 of 42

ANSI C63.19-2011 PERFORMANCE CATEGORIES 3.

I. MAGNETIC COUPLING

Axial and Radial Field Intensity

All orientations of the magnetic field, in the axial and radial position along the measurement plane shall be \geq -18 dB(A/m) at 1 kHz in a 1/3 octave band filter per §8.3.1.

Frequency Response

The frequency response of the axial component of the magnetic field shall follow the response curve specified in EIA RS-504-1983, over the frequency range 300 Hz - 3000 Hz per §8.3.2.

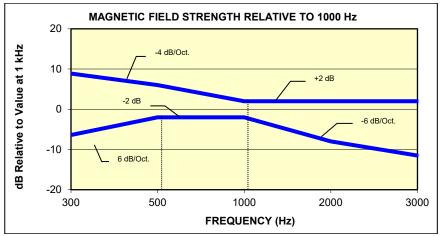


Figure 3-1 Magnetic field frequency response for Wireless Devices with an axial field ≤-15 dB(A/m) at 1 kHz

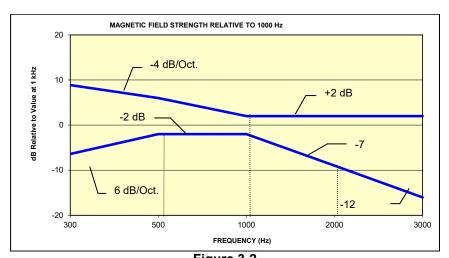


Figure 3-2 Magnetic Field frequency response for wireless devices with an axial field that exceeds -15 dB(A/m) at 1 kHz

FCC ID: A3LSMG998U	PCTEST	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 6 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		rage 6 01 42

© 2021 PCTEST REV 3.5.M

Signal Quality

and microfilm, without permission in writing from PCTES of contents thereof, please contact INFO@PCTEST.COM.

The table below provides the signal quality requirement for the intended audio magnetic signal from a wireless device. Only the RF immunity of the hearing aid is measured in T-coil mode. It is assumed that a hearing aid can have no immunity to an interference signal in the audio band, which is the intended reception band for this mode. The only criterion that can be measured is the RF immunity in T-coil mode. This is measured using the same procedure as the audio coupling mode at the same levels.

The signal quality of the axial and radial components of the magnetic field was used to determine the T-coil mode category.

Catamany	Telephone RF Parameters		
Category	Wireless Device Signal Quality [(Signal + Noise)-to-noise ratio in dB]		
T1	0 to 10 dB		
T2	10 to 20 dB		
Т3	20 to 30 dB		
T4	> 30 dB		
Table 3-1 Magnetic Coupling Parameters			

Note: The FCC limit for SNNR is 20dB and the test data margins will indicate a margin from the FCC limit for compliance.

FCC ID: A3LSMG998U	PCTEST* Proud to be pert of the description	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogo 7 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 7 of 42

METHOD OF MEASUREMENT

Test Setup I.

The equipment was connected as shown in an acoustic/RF hemi-anechoic chamber:

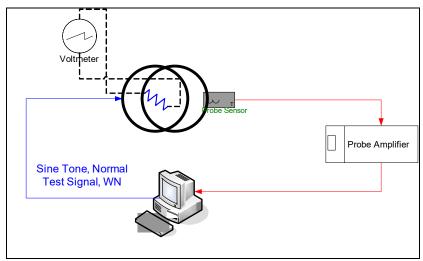


Figure 4-1 Validation Setup with Helmholtz Coil

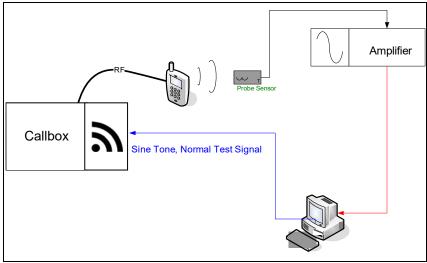


Figure 4-2 **T-Coil Test Setup**

FCC ID: A3LSMG998U	PCTEST* Proud to be port of the simmer	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dama 0 of 40
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 8 of 42
© 2021 PCTEST				REV 3.5.M

8/18/2020

II. Scanning Mechanism

Manufacturer: TEM

Accuracy: ± 0.83 cm/meter

Minimum Step Size: 0.1 mm

Maximum speed 6.1 cm/sec

Line Voltage: 115 VAC

Line Frequency: 60 Hz

Material Composite: Delrin (Acetal)

Data Control: Parallel Port

Dynamic Range (X-Y-Z): 45 x 31.75 x 47 cm

Dimensions: 36" x 25" x 38" Operating Area: 36" x 49" x 55"

Reflections: < -20 dB (in anechoic chamber)

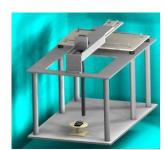


Figure 4-3 RF Near-Field Scanner

III. 3GPP2 Normal Test Signal (Speech)

Manufacturer: 3GPP2 (TIA 1042 §3.3.1)

Modified-IRS weighted, multi-talker speech signal, 4 Male and 4

Stimulus Type: Female speakers (alternating)

Single Sample Duration: 51.62 seconds

Activity Level: 77.4%

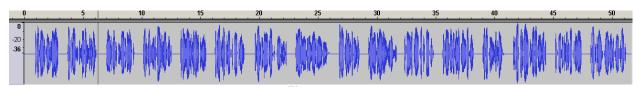
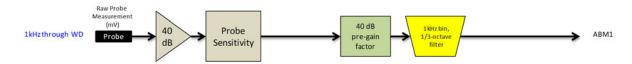


Figure 4-4
Temporal Characteristic of Normal Test Signal

FCC ID: A3LSMG998U	PCTEST Proud to be port of seignment	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogo O of 40
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 9 of 42



ABM2 Measurement Block Diagram:



Figure 4-5 Magnetic Measurement Processing Steps

IV. **Test Procedure**

- 1. Ambient Noise Check per C63.19 §7.3.1
 - Ambient interference was monitored using a Real-Time Analyzer between 100-10,000 Hz with 1/3 octave filtering.
 - "A-weighting" and Half-Band Integration was applied to the measurements.
 - Since this measurement was measured in the same method as ABM2 measurements, this level was verified to be more than 10 dB below the lowest measurement signal (which is the highest ABM2 measurement for a T4 WD). Therefore the maximum noise level for a T4 WD with an ABM1 = -18 dBA/m is:

- 2. Measurement System Validation (See Figure 4-1)
 - a. The measurement system including the probe, pre-amplifier and acquisition system were validated as an entire system to ensure the reliability of test measurements.
 - b. ABM1 Validation

The magnetic field at the center of the Helmholtz coil is given by the equation (per C63.19 Annex D.10.1):

$$H_c = \frac{NI}{r\sqrt{1.25^3}} = \frac{N(\frac{V}{R})}{r\sqrt{1.25^3}}$$

Where H_c = magnetic field strength in amperes per meter N = number of turns per coil

For the Helmholtz Coil, N=20; r=0.08m; R=10.2Ω and using V=18mV:

$$H_c = \frac{20 \cdot (\frac{0.018}{10.2})}{0.08 \cdot \sqrt{1.25^3}} = 0.316A/m \approx -10dB(A/m)$$

Therefore a pure tone of 1kHz was applied into the coils such that 18mV was observed across the resistor. The voltmeter used for measurement was verified to be capable of measurements in the audio band range. This theoretically generates an expected field of -10 dB(A/m) in the center of the Helmholtz coil which was used to validate the probe measurement at -10dB(A/m). This was verified to be within ± 0.5 dB of the -10dB(A/m) value (see Page 21).

FCC ID: A3LSMG998U	PCTEST *	HAC (1-COIL) TEST REPORT		Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 10 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 10 01 42

c. Frequency Response Validation

The frequency response through the Helmholtz Coil was verified to be within 0.5 dB relative to 1kHz, between 300 – 3000 Hz using the Normal signal as shown below:



Figure 4-6 Frequency Response Validation

d. ABM2 Measurement Validation

WD noise measurements are filtered with A-weighting and Half-Band Integration over a frequency range of 100Hz – 10kHz to process ABM2 measurements. Below is the verification of the system processing A-weighting and Half-Band integration between system input to output within 0.5 dB of the theoretical result:

Table 4-1
ABM2 Frequency Response Validation

	HBI, A -	HBI, A -	
f (Hz)	Measured	Theoretical	dB Var.
	(dB re 1kHz)	(dB re 1kHz)	
100	-16.180	-16.170	-0.010
125	-13.257	-13.250	-0.007
160	-10.347	-10.340	-0.007
200	-8.017	-8.010	-0.007
250	-5.925	-5.920	-0.005
315	-4.045	-4.040	-0.005
400	-2.405	-2.400	-0.005
500	-1.212	-1.210	-0.002
630	-0.349	-0.350	0.001
800	0.071	0.070	0.001
1000	0.000	0.000	0.000
1250	-0.503	-0.500	-0.003
1600	-1.513	-1.510	-0.003
2000	-2.778	-2.780	0.002
2500	-4.316	-4.320	0.004
3150	-6.166	-6.170	0.004
4000	-8.322	-8.330	0.008
5000	-10.573	-10.590	0.017
6300	-13.178	-13.200	0.022
8000	-16.241	-16.270	0.029
10000	-19.495	-19.520	0.025

FCC ID: A3LSMG998U	PCTEST *	HAC (I-COIL) TEST REPORT		Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 11 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 11 01 42



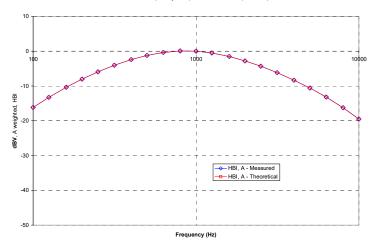
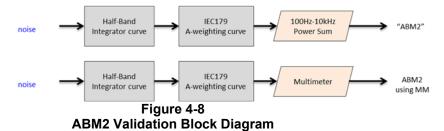


Figure 4-7
ABM2 Frequency Response Validation

The ABM2 result is a power sum from 100Hz to 10kHz with half-band integration and A-weighting. To verify the power sum measurement, a power sum over the full band was measured and verified to track with the source level (See Figure 4-8). Therefore the setup in this step was used to verify the power sum post-processing for ABM2 measurements. See below block diagram:



The power summed output results for a known input were compared to the multi-meter results to verify any deviation in the post-processing implemented with the power-sum.

Table 4-2
ABM2 Power Sum Validation

WN Input (dBV)	Power Sum (dBV)	Multimeter-Full (dBV)	Dev (dB)
-60	-60.36	-60.2	0.16
-50	-50.19	-50.13	0.06
-40	-40.14	-40.03	0.11
-30	-30.13	-30.01	0.12
-20	-20.12	-20	0.12
-10	-10.14	-10	0.14

FCC ID: A3LSMG998U	PCTEST' Proud to be pert of @ named	HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogo 12 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 12 of 42

© 2021 PCTEST REV 3.5.M 8/18/2020

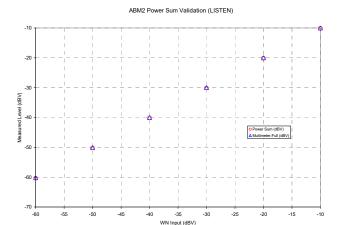
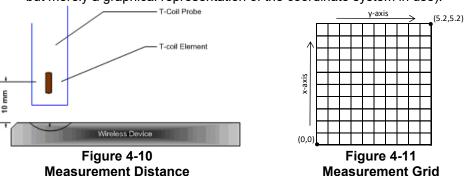


Figure 4-9 **ABM2 Power Sum Validation**

- 3. Measurement Test Setup
 - a. Fine scan above the WD (TEM)
 - i. A multitone signal was applied to the handset such that the phone acoustic output was stable within 1dB over the probe settling time and with the acoustic output level at the C63.19 specified levels (below). The measurement step size was in 2 mm increments at a distance of 10 mm between the surface of the wireless device as shown below (note that in Figure 4-11, the grid is not to scale but merely a graphical representation of the coordinate system in use):



- ii. After scanning, the planar field maximum point was determined. The position of the probe was moved to this location to setup the test using the SoundCheck system.
- iii. These steps were repeated for all T-coil orientations (axial and radial) per Figure 4-13 after a T-coil orientation was fully measured with the SoundCheck system.
- b. Speech Signal Setup to Base Station Simulator
 - i. C63.19 Table 7-1 states audio reference input levels for various technologies:

Standard	Technology	Input Level (dBm0)
TIA/EIA/IS-2000	CDMA	-18
J-STD-007	GSM (217)	-16
T1/T1P1/3GPP	UMTS (WCDMA)	-16
iDEN TM	TDMA (22 and 11 Hz)	-18

FCC ID: A3LSMG998U	PCTEST Proud to be port of a comment	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dags 12 of 12
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 13 of 42

- ii. See Section 5 for more information regarding audio level settings for Over-The-Top (OTT) Voice Over IP (VoIP) Testing.
- c. Real-Time Analyzer (RTA)
 - The Real-Time Analyzer was configured to analyze measurements using 1/3 Octave band weighted filtering.
- d. WD Radio Configuration Selection
 - The device was chosen to be tested in the worst-case ABM2 condition (NR configuration information can be found in Section 5.)
- 4. Signal Quality Data Analysis
 - a. Narrow-band Magnetic Intensity
 - i. The standard specifies a 1kHz 1/3 octave band minimum field intensity for a sine tone. The ABM1 measurements were evaluated at 1kHz with 1/3 octave band filtering over an averaged period of 10 seconds.
 - b. Frequency Response
 - i. The appropriate frequency response curve was measured to curves in Figure 3-1 or Figure 3-2 between 300 3000 Hz using digital linear averaging (limit lines chosen according to measurement found in step 4a). A linear average over 3x the length of the artificial voice signal (3x sampling) was performed. A 10 second delay was configured in the measurement process of the stimulus to ensure handset vocoder latency effects and echo cancellation devices (if any) were appropriately stabilized during measurements.
 - ii. The appropriate post-processing was applied according to the system processing chain illustrated in Figure 4-6. All R10 frequencies were plotted with respect to 0dB at 1kHz value and aligned with respect to the EIA-504 mask.
 - iii. The margin is represented by the closest measured data point on the curve to the EIA-504 limit lines, in dB.
 - c. Signal Quality Index
 - i. Ensuring the WD was at maximum RF power, maximum volume, backlight off, display on, maximum contrast setting, keypad lights on (when possible) with no audio signal through the vocoder, the WD was measured over at least 100 Hz 10,000 Hz, maximized over 5 seconds with a 50ms sample time for the ABM2 measurement (5 second time period is used in noise measurements under standards such as IEEE 269, etc.).
 - ii. After applying half-band integration and A-weighting to the result, a power sum was applied over each 1/3 octave bandwidth frequency for an ABM2 value.
 - This result was subtracted from the ABM1 result in step a, to obtain the Signal Quality.

FCC ID: A3LSMG998U	PCTEST Proud to be port of seignment	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 14 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Faye 14 01 42

V. Test Setup

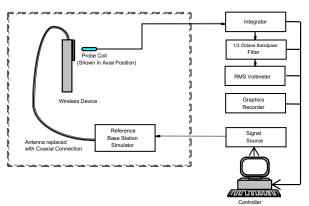


Figure 4-12
Audio Magnetic Field Test Setup

Environmental conditions such as temperature and relative humidity are monitored to ensure there are no impacts on system specifications. Proper voltage and power line frequency conditions are maintained with three phase power sources. Environmental noise and reflections are monitored through system checks.

VI. Deviation from C63.19 Test Procedure

Non-conducted RF connection due to inaccessible RF ports.

VII. Air Interface Technologies Tested

All air interfaces which support voice capabilities over a managed CMRS or pre-installed OTT VoIP applications were tested for T-coil unless otherwise noted. See Table 2-1 for more details regarding which modes were tested.

VIII. Wireless Device Channels and Frequencies

1. 5G (NR) Modes

The middle channel and supported bandwidths from the worst-case NR n77 SRS antenna according to Table 5-1 was evaluated with OTT VoIP for each probe orientation. The bandwidth combination from each probe orientation resulting in the worst-case SNNR was additionally tested using low, low-mid, mid-high, and high channels for that band and bandwidth combination. See Table 6-2 for NR bandwidths and channels.

FCC ID: A3LSMG998U	PCTEST HAC (T-COIL) TEST REPORT		SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 15 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 15 01 42

© 2021 PCTEST REV 3.5.M

IX. **Test Flow**

The flow diagram below was followed (From C63.19):

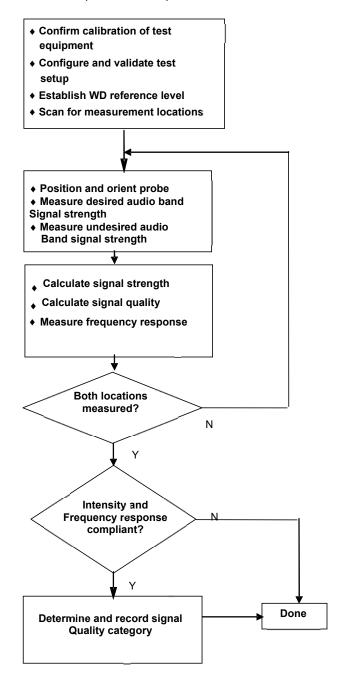


Figure 4-13 **C63.19 T-Coil Signal Test Process**

FCC ID: A3LSMG998U	PCTEST 1	HAC (1-COIL) TEST REPORT		Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 16 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 10 01 42

5. OTT VOIP TEST SYSTEM AND DUT CONFIGURATION

I. Test System Setup for OTT VolP T-Coil Testing

1. OTT VoIP Application

Google Duo is a pre-installed application on the DUT which allows for VoIP calls in a held-to-ear scenario. Duo uses the OPUS audio codec and supports a bitrate range of 6kb/s to 75kb/s. All air interfaces capable of a data connection were evaluated with Google Duo.

2. Equipment Setup

A CMW500 callbox was used to perform OTT VoIP T-coil measurements. The Data Application Unit (DAU) of the CMW500 was connected to the internet and allowed for an IP data connection on the DUT. An auxiliary VoIP unit was used to initiate an OTT VoIP call to the DUT. The auxiliary VoIP unit allowed for the configuration and monitoring of the OTT VoIP codec bitrate during a call. Both high and low bitrate settings were evaluated in to determine the worst-case configuration.

3. Audio Level Settings

According to KDB 285076 D02, the average speech level of -20dBm0 shall be used for protocols not specifically listed in Table 7.1 of ANSI C63.19-2011 or the ANSI C63.19-2011 VoLTE interpretation². The auxiliary VoIP unit allowed for monitoring the signal input level to ensure that the settings for speech input and full scale levels resulted in the -20dBm0 speech input level to the DUT for the OTT VoIP call.

Note: The green highlighted text is approved by FCC under the TCB PAG Re-Use Policy 388624 D01 IV. D. for T-Coil Testing for WI-FI calling and Google Duo.

II. DUT Configuration for OTT VoIP T-Coil Testing

1. Interim Procedure for evaluation OTT VoIP (NR)

The following procedure is used to evaluate OTT VoIP (NR) given equipment limitations.

- a. This procedure is applicable for OTT VoIP (NR) voice calls that use the same protocol, codec(s), and reference level as OTT VoIP (LTE) (i.e. -20dBm0).
- b. Establish the ABM1_{NR} value by using the ABM1_{LTE} magnetic intensity for an LTE call using a correlating LTE band through existing procedures and test equipment.
- c. Establish an ABM2_{NR} value using factory test mode (FTM) to simulate a NR connection for the desired NR band and channel under test.
- d. The following information is documented in Section 9:
 - i. ABM2LTE and ABM2NR for respective tests.
 - ii. Calculate SNNR:
 - 1. $ABM1 = ABM1_{LTE}$
 - 2. $ABM2 = ABM2_{NR}$
 - 3. SNNR_{NR} = [ABM1_{LTE} ABM2_{NR}] 3dB
 - a. A 3dB margin is built in to ensure conservative results with this interim procedure.

² FCC Office of Engineering and Technology KDB, "285076 D02 T-Coil Testing for CMRS IP v03," September 13, 2017

FCC ID: A3LSMG998U	PCTEST* Proud to be part of the element	HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogg 17 of 10
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 17 of 42

© 2021 PCTEST REV 3.5.M

The above is only applicable for OTT VoIP scenarios, this device does not support VoNR over IMS.

The manufacturer has confirmed the handset as designed is expected to exhibit similar audio intensity levels between an OTT VoIP call placed over a 4G LTE and a 5G Sub-6GHz data connection.

2. Radio Configuration for OTT VoIP (NR)

An investigation was performed to determine the waveform, modulation, and RB configuration to be used for testing. Please see the original certification test report for more information. Due to equipment limitations, the procedure outlined in 5.II.1 was used to evaluate the SNNR for each radio configuration below. DFT-s-OFDM 16QAM, 1RB, 99%RB offset was determined to be the worst-case configuration for the handset and will be used for full testing in Section 6.

An investigation was performed to determine the worst-case NR n77 SRS Tx antenna to be used for OTT VoIP testing, NR n77 Ant D was used for the testing as the worst-case configuration for the handset. See below table for SNNR comparison between different NR TDD bands:

> Table 5-1 OTT VoIP (NR TDD) SNNR by Band

Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Waveform	Modulation	RB Size	RB Offset	ABM1 _{LTE} [dB(A/m)]	ABM2 _{NR} [dB(A/m)]	SNNR _{NR} [dB]
n77 - Ant I	3840.0	656000	100	DFT-s-OFDM	16QAM	1	271	11.72	-40.02	51.74
n77 - Ant B	3840.0	656000	100	DFT-s-OFDM	16QAM	1	271	11.72	-37.56	49.28
n77 - Ant G	3840.0	656000	100	DFT-s-OFDM	16QAM	1	271	11.72	-39.93	51.65
n77 - Ant D	3840.0	656000	100	DFT-s-OFDM	16QAM	1	271	11.72	-36.96	48.68

Note: The ABM1 used in table 5-1 is from a correlating LTE band evaluated in the Original Certification Report. Please see that report for more information.

FCC ID: A3LSMG998U	PCTEST* Proud to be part of the element	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager	
Filename:	Test Dates:	DUT Type:		Dogo 19 of 42	
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 18 of 42	

T-COIL TEST SUMMARY

Table 6-1 **Consolidated Tabled Results**

Concentration resource									
C63.19 Section		_	esponse rgin	Intensity Verdict Verdict		Margin from	C63.19-2011		
		8.3.2		8.3.1		8.3.4		(dB)	Rating
C05. 18	Cos. 19 Section		Radial	Axial	Radial	Axial	Radial		
NR TDD (OTT VoIP)	n77 - Ant D	NA	NA	PASS	PASS	PASS	PASS	-14.51	Т4

I. **Raw Handset Data**

Table 6-2 Raw Data Results for NR n77 (OTT VolP)

	Raw Data Results for NR n// (OTT VOIP)													
Mode	Orientation	Bandwidth	Channel	ABM1 _{LTE} [dB(A/m)]	ABM2 _{NR} [dB(A/m)]	ABM2 _{LTE} [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N _{NR} (dB)	S+N/N _{NR} - 3 dB (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
		100MHz	650000	11.40	-39.67	-49.69			51.07	48.07	20.00	-28.07	T4	
		100MHz	653000	11.40	-38.16	-49.69			49.56	46.56	20.00	-26.56	T4	
		100MHz	656000	11.40	-36.89	-49.69			48.29	45.29	20.00	-25.29	T4	i l
		100MHz	659000	11.40	-36.92	-49.69			48.32	45.32	20.00	-25.32	T4	
		100MHz	662000	11.40	-36.81	-49.69			48.21	45.21	20.00	-25.21	T4	j l
		90MHz	656000	11.40	-36.95	-49.69			48.35	45.35	20.00	-25.35	T4	
	Axial	80MHz	656000	11.40	-36.96	-49.69	-63.11	N/A	48.36	45.36	20.00	-25.36	T4	1.4, 1.2
		70MHz	656000	11.40	-37.14	-49.69			48.54	45.54	20.00	-25.54	T4	
		60MHz	656000	11.40	-37.07	-49.69			48.47	45.47	20.00	-25.47	T4	
		50MHz	656000	11.40	-37.11	-49.69			48.51	45.51	20.00	-25.51	T4	
		40MHz	656000	11.40	-37.33	-49.69			48.73	45.73	20.00	-25.73	T4	
		30MHz	656000	11.40	-37.48	-49.69			48.88	45.88	20.00	-25.88	T4	
NR n77 -		20MHz	656000	11.40	-37.68	-49.69			49.08	46.08	20.00	-26.08	T4	
Ant D		100MHz	650000	3.34	-37.03	-44.22			40.37	37.37	20.00	-17.37	T4	4
		100MHz	653000	3.34	-35.48	-44.22			38.82	35.82	20.00	-15.82	T4	
		100MHz	656000	3.34	-34.49	-44.22			37.83	34.83	20.00	-14.83	T4	
		100MHz	659000	3.34	-34.17	-44.22			37.51	34.51	20.00	-14.51	T4	
		100MHz	662000	3.34	-34.40	-44.22			37.74	34.74	20.00	-14.74	T4	
		90MHz	656000	3.34	-34.67	-44.22			38.01	35.01	20.00	-15.01	T4	
	Radial	80MHz	656000	3.34	-34.79	-44.22	-64.55	N/A	38.13	35.13	20.00	-15.13	T4	1.4, 0.4
		70MHz	656000	3.34	-35.01	-44.22			38.35	35.35	20.00	-15.35	T4	
		60MHz	656000	3.34	-35.02	-44.22			38.36	35.36	20.00	-15.36	T4	
		50MHz	656000	3.34	-34.75	-44.22]		38.09	35.09	20.00	-15.09	T4	
		40MHz	656000	3.34	-34.83	-44.22			38.17	35.17	20.00	-15.17	T4	
		30MHz	656000	3.34	-34.90	-44.22			38.24	35.24	20.00	-15.24	T4	
		20MHz	656000	3.34	-35.30	-44.22			38.64	35.64	20.00	-15.64	T4	

Table 6-3 Raw Data Results for LTE B48 (OTT VoIP - Additional Measurements for NR)

Mod	e Or	rientation	Bandwidth	Channel	ABM1 _{LTE} [dB(A/m)]	ABM2 _{NR} [dB(A/m)]	ABM2 _{LTE} [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N _{LTE} (dB)	S+N/N _{NR} - 3 dB (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE B	and	Axial	20MHz	55990	11.40	N/A	-49.69	-63.11	N/A	61.09	N/A	20.00	-41.09	T4	1.4, 1.2
48		Radial	20MHz	55990	3.34	IN/A	-44.22	-64.55	IN/A	47.56	IVA	20.00	-27.56	T4	1.4, 0.4

FCC ID: A3LSMG998U	PCTEST* Proud to be post of the element	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 19 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Faye 19 01 42

II. Test Notes

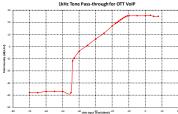
A. General

- 1. Phone Condition: Mute on; Backlight off; Max Volume; Max Contrast
- 2. 'Radial' orientation refers to radial transverse.
- 3. Hearing Aid Mode (Phone→Call settings→Other call settings→Hearing aid compatibility) was set to ON for T-Coil testing
- 4. Bluetooth and WIFI were disabled while testing 5G modes.
- 5. The Margin from FCC limit column indicates a margin from the FCC limit for compliance (T4).

B. OTT VoIP

- 1. Vocoder Configuration: 75kbps
 - a. Please refer to the Original Certification test report for more information regarding vocoder configuration selection.
- 2. NR TDD Configuration
 - a. Power Configuration: TxAGC is set such that the DUT operates at max power.
 - b. Radio Configuration: DFT-s-OFDM, 16QAM, 1RB, 99%RB Offset
 - Please refer to the Original Certification test report for more information regarding radio configuration selection
 - c. Due to equipment limitations, ABM1 measurements were not possible. Therefore, the procedure outlined in Section 5.II.1 was followed to obtain SNNR values. Additionally, Frequency Response measurements were not possible due to equipment limitations.
 - d. NR Band n77 Ant D was the worst-case band from Table 5-1 and was used to test both Axial and Radial probe orientations.
 - e. The worst-case band and bandwidth combination for each probe orientation is additionally tested on the low, low-mid, mid-high, and high channels for those combinations. NR n77 at 100MHz is the worst-case for both the Axial and Radial probe orientations.

III. 1 kHz Vocoder Application Check



This model was verified to be within the linear region for ABM1 measurements at -20 dBm0 for OTT VoIP. This measurement was taken in the axial configuration above the maximum location.

FCC ID: A3LSMG998U	PCTEST	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dags 20 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 20 of 42

IV. T-Coil Validation Test Results

Table 6-4
Helmholtz Coil Validation Table of Results

Item	Target	Result	Verdict
Axial			
Magnetic Intensity, -10 dBA/m	-10 ± 0.5 dB	-9.952	PASS
Environmental Noise	< -58 dBA/m	-63.11	PASS
Frequency Response, from limits	> 0 dB	0.50	PASS
Radial			
Magnetic Intensity, -10 dBA/m	-10 ± 0.5 dB	-10.164	PASS
Environmental Noise	< -58 dBA/m	-64.55	PASS
Frequency Response, from limits	> 0 dB	0.70	PASS

FCC ID: A3LSMG998U	PCTEST* Proud to be pert of the decreased	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogo 21 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 21 of 42

ABM1 Magnetic Field Distribution Scan Overlays ٧.

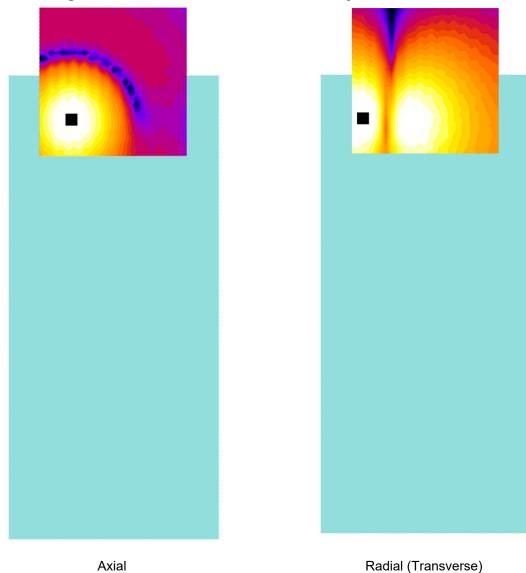


Figure 6-1
T-Coil Scan Overlay Magnetic Field Distributions

Notes:

- 1. Final measurement locations are indicated by a cursor on the contour plots.
- 2. See Test Setup Photographs for actual WD overlay.

FCC ID: A3LSMG998U	PCTEST Proud to be port of seinment	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogg 22 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 22 of 42

© 2021 PCTEST **REV 3.5.M**

7. MEASUREMENT UNCERTAINTY

Table 7-1 Uncertainty Estimation Table

Contribution	Data +/- %	Data +/- dB	Data Type	Probability distribution	Divisor	Standard uncertainty	Standard Uncertainty (dB)
ABM Noise	7.0%	0.29	Std. Dev.	Normal k=1	1.00	7.0%	
RF Reflections	4.7%	0.20	Specification	Rectangular	1.73	2.7%	
Reference Signal Level	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Positioning Accuracy	10.0%	0.41	Uncertainty	Rectangular	1.73	5.8%	
Probe Coil Sensitivity	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Probe Linearity	2.4%	0.10	Std. Dev.	Normal k=1	1.00	2.4%	
Cable Loss	2.8%	0.12	Specification	Rectangular	1.73	1.6%	
Frequency Analyzer	5.0%	0.21	Specification	Rectangular	1.73	2.9%	
System Repeatability	5.0%	0.21	Std. Dev.	Normal k=1	1.00	5.0%	
WD Repeatability	9.0%	0.37	Std. Dev.	Normal k=1	1.00	9.0%	
Positioner Accuracy	1.0%	0.04	Specification	Rectangular	1.73	0.6%	
Combined standard uncertainty, uc (k=1)							0.71
Expanded uncertainty (k=2),	35.3%	1.31					

Notes:

- 1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297.
- All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid compatibility tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

FCC ID: A3LSMG998U	PCTEST* Proud to be pert of the decreased	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogg 22 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 23 of 42

EQUIPMENT LIST 8.

Table 8-1 **Equipment List**

Manufacturer Model Description Cal Date Cal Interval Cal Due Serial Number Dell Latitude E6540 SoundCheck Acoustic Analyzer Laptop 9/29/2020 Biennial 9/29/2022 2655082910 Listen SoundConnect Microphone Power Supply 9/24/2020 Biennial 9/24/2022 0899-PS150 RME Fireface UC Soundcheck Acoustic Analyzer External Audio Interface 9/29/2020 Biennial 9/29/2022 23792992 Seekonk NC-100 Torque Wrench (8" lb) 8/4/2020 Biennial 8/4/2022 21053 TEM HAC Positioner N/A N/A N/A TEM Helmholtz Coil N/A N/A N/A TEM Helmholtz Coil 9/23/2020 Biennial 9/23/2022 SBI 1052 TEM Axial T Gill Broba 9/23/2020 Rionalal 9/23/2020 TEM 1132			=900 =				
Listen SoundConnect Microphone Power Supply 9/24/2020 Biennial 9/24/2022 0899-PS150 RME Fireface UC Soundcheck Acoustic Analyzer External Audio Interface 9/29/2020 Biennial 9/29/2022 23792992 Seekonk NC-100 Torque Wrench (8" lb) 8/4/2020 Biennial 8/4/2022 21053 TEM HAC Positioner N/A N/A N/A TEM HAC System Controller with Software N/A N/A N/A TEM Helmholtz Coil 9/23/2020 Biennial 9/23/2022 SBI 1052	Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
RME Fireface UC Soundcheck Acoustic Analyzer External Audio Interface 9/29/2020 Biennial 9/29/2022 23792992 Seekonk NC-100 Torque Wrench (8" lb) 8/4/2020 Biennial 8/4/2022 21053 TEM HAC Positioner N/A N/A N/A TEM HAC System Controller with Software N/A N/A N/A TEM Helmholtz Coil 9/23/2020 Biennial 9/23/2022 SBI 1052	Dell	Latitude E6540	SoundCheck Acoustic Analyzer Laptop	9/29/2020	Biennial	9/29/2022	2655082910
Seekonk NC-100 Torque Wrench (8" lb) 8/4/2020 Biennial 8/4/2022 21053 TEM HAC Positioner N/A N/A N/A TEM HAC System Controller with Software N/A N/A N/A TEM Helmholtz Coil Helmholtz Coil 9/23/2020 Biennial 9/23/2022 SBI 1052	Listen	SoundConnect	Microphone Power Supply	9/24/2020	Biennial	9/24/2022	0899-PS150
TEM HAC Positioner N/A N/A N/A TEM HAC System Controller with Software N/A N/A N/A TEM Helmholtz Coil Helmholtz Coil 9/23/2020 Biennial 9/23/2022 SBI 1052	RME	Fireface UC	Soundcheck Acoustic Analyzer External Audio Interface	9/29/2020	Biennial	9/29/2022	23792992
TEM HAC System Controller with Software N/A N/A N/A TEM Helmholtz Coil Helmholtz Coil 9/23/2020 Biennial 9/23/2022 SBI 1052	Seekonk	NC-100	Torque Wrench (8" lb)	8/4/2020	Biennial	8/4/2022	21053
TEM Helmholtz Coil Helmholtz Coil 9/23/2020 Biennial 9/23/2022 SBI 1052	TEM		HAC Positioner	N/A		N/A	N/A
	TEM		HAC System Controller with Software	N/A		N/A	N/A
TEM Avial T Coil Broho Avial T Coil Broho 0/32/2020 Rionnial 0/22/2022 TEM 1122	TEM	Helmholtz Coil	Helmholtz Coil	9/23/2020	Biennial	9/23/2022	SBI 1052
TEIVI AXIGIT-COTIFTODE AXIGIT-COTIFTODE 9/25/2020 BIETITIGI 9/25/2022 TEIVI-1125	TEM	Axial T-Coil Probe	Axial T-Coil Probe	9/23/2020	Biennial	9/23/2022	TEM-1123
TEM Radial T-Coil Probe Radial T-Coil Probe 9/23/2020 Biennial 9/23/2022 TEM-1129	TEM	Radial T-Coil Probe	Radial T-Coil Probe	9/23/2020	Biennial	9/23/2022	TEM-1129

FCC ID: A3LSMG998U	PCTEST* Proud to be part of a decreed	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogo 24 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 24 of 42

TEST DATA 9.

FCC ID: A3LSMG998U	PCTEST*	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogo 25 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 25 of 42

© 2021 PCTEST REV 3.5.M



PCTEST Hearing-Aid Compatibility Facility

DUT: HH Coil - SN: SBI 1052

Type: HH Coil Serial: SBI 1052

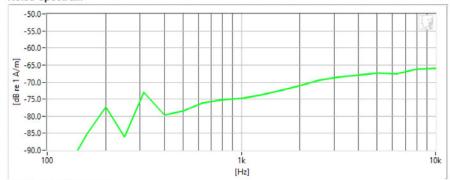
Measurement Standard: ANSI C63.19-2011

Equipment:

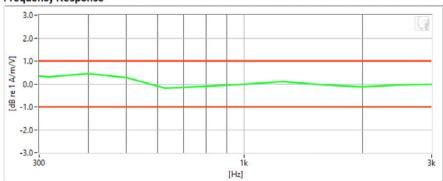
Probe: Axial T-Coil Probe - SN: TEM-1123; Calibrated: 09/23/2020

Helmholtz Coil - SN: SBI 1052; Calibrated: 09/23/2020

Noise Spectrum



Frequency Response



Results

Verification 1kHz Intensity	-9.952 dB	\checkmark	Max/Min	-9.5/-10.5
Verification ABM2	-63.11 dB	•	Maximum	-58.0
Frequency Response Margin	500m dB	~	Tolerance curves	Aligned Data

FCC ID: A3LSMG998U	PCTEST*	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 26 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 20 01 42



DUT: HH Coil - SN: SBI 1052

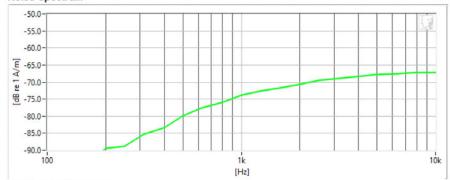
Type: HH Coil Serial: SBI 1052

Measurement Standard: ANSI C63.19-2011

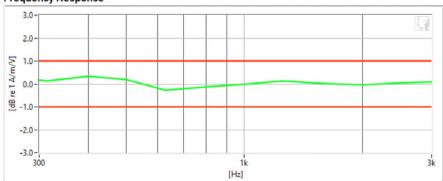
Equipment:

- Probe: Radial T-Coil Probe SN: TEM-1129; Calibrated: 09/23/2020
- Helmholtz Coil SN: SBI 1052; Calibrated: 09/23/2020

Noise Spectrum



Frequency Response



Results

Verification 1kHz Intensity	-10.164	dB	\checkmark	Max/Min	-9.5/-10.5
Verification ABM2	-64.55	dB	•	Maximum	-58.0
Frequency Response Margin	700m	dB	~	Tolerance curves	Aligned Data

FCC ID: A3LSMG998U	PCTEST*	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 27 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 27 01 42



DUT: A3LSMG998U

Type: Portable Handset Serial: 3972S

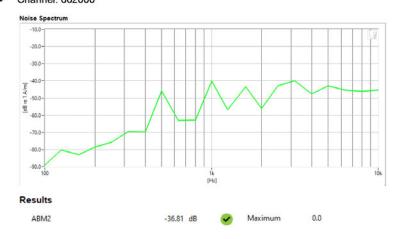
Measurement Standard: ANSI C63.19-2011

Equipment:

Probe: Axial T-Coil Probe – SN: TEM-1123; Calibrated: 09/23/2020

Test Configuration:

· VolP Application: Google Duo Mode: NR TDD n77 Bandwidth: 100MHz Channel: 662000



FCC ID: A3LSMG998U	PCTEST	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogg 20 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 28 of 42



DUT: A3LSMG998U

Type: Portable Handset Serial: 3972S

Measurement Standard: ANSI C63.19-2011

Equipment:

Probe: Radial T-Coil Probe – SN: TEM-1129; Calibrated: 09/23/2020

Test Configuration:

· VolP Application: Google Duo Mode: NR TDD n77 Bandwidth: 100MHz Channel: 659000

Noise Spectrum



FCC ID: A3LSMG998U	PCTEST*	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 29 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		raye 29 01 42

10. CALIBRATION CERTIFICATES

FCC ID: A3LSMG998U	PCTEST*	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 30 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 30 01 42

1M2012210203-05-R1.A3L 02/08/2021 - 02/12/2021 Portable Handset Page 30 of 42

© 2021 PCTEST REV 3.5.M



Certificate of Conformance

AXIAL T COIL PROBE

Manufactured by: TEM CONSULTING Model No: AXIAL T COIL PROBE

Serial No: TEM-1123 Calibration Recall No: 31288

Submitted By:

ANDREW HARWELL Customer:

PCTEST ENGINEERING LAB Company:

Address: 6660-B DOBBIN ROAD

COLUMBIA MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the SI through the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No.

AXIAL T C TEM C

Upon receipt for Calibration, the instrument was found to be:

 (\mathbf{x})

tolerance of the indicated specification. See attached Report of Calibration. The information supplied relates to the calibrated item listed above and statment of conformance for ALL given specifications and standards fall under the decision rule: A=(L-(U95)), where A is acceptance limit, L is manufacturer specifications and U95 is confidence level of 95% at k=2. This includes but not limited to:1. Measured value does not meet manufacturer's tolerance, 2.Manufacturer's tolerance is too small compared to calibration and measurment capability uncertainties, 3. Test uncertainty ratio does not meet the 4:1 ratio due to test instrumentation limitations. The decision rule has been communicated and approved by customer during contract

West Caldwell Calibration Laboratories' calibration control system meets the following requirements, ISO 10012-1 MIL STD 45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2015, and ISO 17025

Note: With this Certificate, Report of Calibration is included.

Approved by:

Calibration Date: 23-Sep-20 James Zhu

31288 - 2 Certificate No:

Quality Manager ISO/IEC 17025:2017

QA Doc. #1051 Rev. 3.0 5/29/20 Certificate Page 1 of 1

> ACCREDITED Calibration Lab. Cert. # 1533.01

Calibration uncompromised calibration Laboratories, Inc.

1575 State Route 96, Victor, NY 14564, U.S.A.

West Caldwell

Approved by: FCC ID: A3LSMG998U HAC (T-COIL) TEST REPORT SAMSUNG Quality Manager DUT Type: Filename: Test Dates: Page 31 of 42 1M2012210203-05-R1.A3L 02/08/2021 - 02/12/2021 Portable Handset

© 2021 PCTEST



ACCREDITED

ISO/IEC 17025: 2017

1575 State Route 96, Victor NY 14564

Calibration Lab. Cert. # 1533.01

REPORT OF CALIBRATION

for

TEM Consulting LP Axial T Coil Probe Company: PCTest Engineering Lab

Model No.: Axial T Coil Probe

Serial No.: TEM-1123

I. D. No.: XXXX

Probe Sensitivity measured wit	h Helmholi	tz Coil			
Helmholtz Coil;			Before & after data same:	X	
the number of turns on each coil;	10	No.			
the radius of each coil, in meters;	0.204	m	Laboratory Environment:		
the current in the coils, in amperes.;	0.08	Α	Ambient Temperature:	20.7	°C
Helmholtz Coil Constant;	7.04	A/m/V	Ambient Humidity:	42.1	% RH
Helmholtz Coil magnetic field;	5.71	A/m	Ambient Pressure:	99.094	kPa
			Calibration Date:	23-Sep-2020	
Probe Sensitivity at	1000	Hz.	Calibration Due:		
was	-60.24	dBV/A/m	Report Number:	31288	-2
	0.972	mV/A/m	Control Number:	31288	
Probe resistance	898	Ohms			

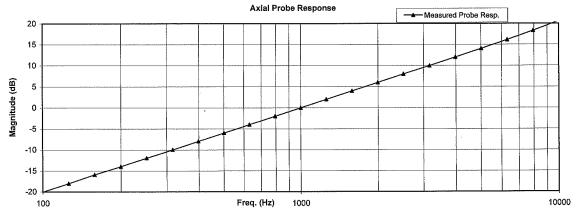
The above listed instrument meets or exceeds the tested manufacturer's specifications.

This Calibration is traceable through NIST test numbers: 6

684.07/O-0000001126-20

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015 ISO 17025

Cal. Date: 23-Sep-2020

Measurements performed by:

James Zhu

Calibrated on WCCL system type 9700

This document shall not be reproduced, except in full, without the written approval from West Caldwell Cal. Labs. Inc.

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Page 1 of 2

FCC ID: A3LSMG998U	PCTEST Proved to be port of @ comment	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 32 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		1 age 02 01 42

HCATEMC_TEM-1123_Sep-23-2020

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

for

TEM Consulting LP Axial T Coil Probe Company: PCTest Engineering Lab

Model No.: Axial T Coil Probe

Serial No.: TEM-1123

Test	Function	Tolera	nce	Measured values			
*******				Before	Out	Remarks	
1.0	Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.24			
			dB				
2.0	Probe Level Linearity		6	6.03			
		Ref. (0 dB)	0	0.00			
			-6	-6.03			
			-12	-12.05			
			Hz				
3.0	Probe Frequency Response		100	-20.0		1	
			126	-18.0			
			158	-15.9			
			200	-14.0			
			251	-12.0			
			316	-10.0			
			398	-8.0		İ	
			501	-6.0			
			631	-4.0			
		D - 6 (0 -1D)	794	-2.0			
		Ref. (0 dB)	1000	0.0			
			1259 1585	2.0 4.0			
			1995	6.0			
			2512	8.0			
			3162	10.0			
			3981	12.0			
			5012	14.0			
			6310	16.1			
			7943	18.3			
			10000	20.7			

Instruments u	sed for calibration:		Date of Cal.	Traceablity No.	Due Date
HP	34401A	S/N US360641	2-Jul-2020	,610119	2-Jul-2021
HP	34401A	S/N US361024	2-Jul-2020	,610119	2-Jul-2021
HP	33120A	S/N US360437	2-Jul-2020	,610119	2-Jul-2021
B&K	2133	S/N 1583254	1-Jul-2020	684.07/O-0000001126-20	1-Jul-2021

Cal. Date: 23-Sep-2020

Calibrated on WCCL system type 9700

This document shall not be reproduced, except in full, without the written approval from West Caldwell Cal. Labs. Inc.

Tested by: James Zhu

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Page 2 of 2

FCC ID: A3LSMG998U	PCTEST*	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 33 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		raye 33 01 42



Certificate of Conformance

for

RADIAL T COIL PROBE

Manufactured by:

TEM CONSULTING

Model No:

RADIAL T COIL PROBE

Serial No:

TEM-1129

Calibration Recall No:

Submitted By:

Customer:

ANDREW HARWELL

31288

Company:

PCTEST ENGINEERING LAB

Address:

6660-B DOBBIN ROAD

COLUMBIA

MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the SI through the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No.

RADIAL T TEM C

19/13/2020

Upon receipt for Calibration, the instrument was found to be:

Within (X

tolerance of the indicated specification. See attached Report of Calibration.

The information supplied relates to the calibrated item listed above and statment of conformance for ALL given specifications and standards fall under the decision rule: A=(L-(U95)), where A is acceptance limit, L is manufacturer specifications and U95 is confidence level of 95% at k=2. This includes but not limited to:1. Measured value does not meet manufacturer's tolerance, 2.Manufacturer's tolerance is too small compared to calibration and measurement capability uncertainties, 3. Test uncertainty ratio does not meet the 4:1 ratio due to test instrumentation limitations. The decision rule has been communicated and approved by customer during contract

West Caldwell Calibration Laboratories' calibration control system meets the following requirements, ISO 10012-1 MIL STD 45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2015, and ISO 17025

Note: With this Certificate, Report of Calibration is included.

Approved by:

Calibration Date:

23-Sep-20

James Zhu

Certificate No:

31288 -1

West Caldwell

Quality Manager ISO/IEC 17025:2017

QA Doc. #1051 Rev. 3.0 5/29/20

Certificate Page 1 of 1

ACCREDITED

Calibration uncompromised calibration Laboratories. Inc.

1575 State Route 96, Victor, NY 14564, U.S.A.

Calibration Lab. Cert. # 1533.01

 FCC ID: A3LSMG998U
 PCTEST
 HAC (T-COIL) TEST REPORT
 Approved by: Quality Manager

 Filename:
 1M2012210203-05-R1.A3L
 DUT Type:
 Page 34 of 42

© 2021 PCTEST

REV 3.5.M



ISO/IEC 17025: 2017

ACCREDITED

Calibration Lab. Cert. # 1533.01

1575 State Route 96, Victor NY 14564

REPORT OF CALIBRATION

for

TEM Consulting LP Radial T Coil Probe Company: PCTest Engineering Lab

Model No.: Radial T Coil Probe

Serial No.: TEM-1129 I. D. No.: XXXX

Calibration results: Probe Sensitivity measured with Helmholtz Coil Helmholtz Coil: Before & after data same: ... X... the number of turns on each coil: 10 No. the radius of each coil, in meters; 0.204 m Laboratory Environment: ٥C the current in the coils, in amperes.; 0.08 Α Ambient Temperature: 20.7 Helmholtz Coil Constant; 7.04 A/m/V Ambient Humidity: 42.1 % RH Helmholtz Coil magnetic field; 5.70 Ambient Pressure: 99.094 kPa Calibration Date: 23-Sep-2020 Probe Sensitivity at 1000 Hz. Re-calibration Due: -60.37 dBV/A/m Report Number: 31288 -1 was 31288 mV/A/m 0.959 Control Number: Ohms Probe resistance 897

The above listed instrument meets or exceeds the tested manufacturer's specifications. This Calibration is traceable through NIST test numbers: 684.07/O-0000001126-20 The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Graph represents Probes Frequency Response.

Radial Probe Response

Measured Probe Resp.

The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015, ISO 17925 intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015, ISO 17925 intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015, ISO 17925 intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015, ISO 17925 intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015, ISO 17925 intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015, ISO 17925 intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015, ISO 17925 intended to implement the requirement of ISO 17925 intended to implement the requirement of ISO 17925 intended to implement the ISO 17925 intended the ISO 17925 intended to implement th

Cal. Date: 23-Sep-2020

Measurements performed by:

Calibrated on WCCL system type 9700

James Zhu

This document shall not be reproduced, except in full, without the written approval from West Caldwell Cal, Labs, Inc.

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

Page 1 of 2

FCC ID: A3LSMG998U	PCTEST*	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 35 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Fage 33 01 42

HCRTEMC_TEM-1129_Sep-23-2020

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

for

TEM Consulting LP Radial T Coil Probe Company: PCTest Engineering Lab

Model No.: Radial T Coil Probe

Serial No.: TEM-1129

Function	Function Tolerance			Measured values		
			Before	Out	Remarks	
Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.37			
		dB			-	
Probe Level Linearity		6	6.04			
	Ref. (0 dB)	0	0.00			
		-6	-6.03			
		-12	-12.05			
		Hz				
Probe Frequency Response			1			
•						
]	
	Ref. (0 dB)					
		10000	20.7			
	**************************************	Probe Sensitivity at 1000 Hz. Probe Level Linearity Ref. (0 dB)	Probe Sensitivity at 1000 Hz. dBV/A/m Probe Level Linearity 6 Ref. (0 dB) 0 -6 -12 Probe Frequency Response 100 126 158 200 251 316 398 501 631 794	Probe Sensitivity at 1000 Hz. dBV/A/m -60.37 Probe Level Linearity 6 6 6.04 Ref. (0 dB) 0 0.00 -6 -6.03 -12 -12.05 Probe Frequency Response 100 -20.0 158 -16.0 200 -14.0 251 -12.0 316 -10.0 398 -8.0 501 -6.0 631 -4.0 794 -2.0 Ref. (0 dB) 1000 0.0 1259 2.0 Ref. (0 dB) 1000 0.0 1259 2.0 1585 4.0 1995 6.0 2512 8.0 3162 10.0 3981 12.0 5012 14.0 5012 14.0 6310 16.1 7943 18.3	Probe Sensitivity at 1000 Hz. dBV/A/m -60.37 Probe Level Linearity 6	

Instrumen	ts used for calibration:		Date of Cal.	Traceability No.	Due Date
HP	34401A	S/N US360641	2-Jul-2020	,610119	2-Jul-2021
HP	34401A	S/N US361024	2-Jul-2020	.610119	2-Jul-2021
HP	33120A	S/N US360437	2-Jul-2020	.610119	2-Jul-2021
B&K	2133	S/N 1583254	1-Jul-2020	684.07/O-0000001126-20	1-Jul-2021

Cal. Date: 23-Sep-2020

Calibrated on WCCL system type 9700

This document shall not be reproduced, except in full, without the written approval from West Caldwell Cal. Labs. Inc.

Tested by: James Zhu

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

Page 2 of 2

FCC ID: A3LSMG998U	PCTEST*	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 36 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		raye 30 01 42

11. CONCLUSION

The measurements indicate that the NR n77 wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

FCC ID: A3LSMG998U	PCTEST* Proud to be pert of the decreased	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename: Test Dates:		DUT Type:		Dogg 27 of 40
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 37 of 42

12. REFERENCES

- ANSI C63.19-2011, American National Standard for Methods of Measurement of Compatibility between Wireless communication devices and Hearing Aids.", New York, NY, IEEE, May 2011
- 2. FCC Office of Engineering and Technology KDB, "285076 D01 HAC Guidance v05," September 13, 2017
- 3. FCC Office of Engineering and Technology KDB, "285076 D02 T-Coil Testing for CMRS IP v03," September 13, 2017
- FCC Public Notice DA 06-1215, Wireless Telecommunications Bureau and Office of Engineering and Technology Clarify
 Use of Revised Wireless Phone Hearing Aid Compatibility Standard, June 6, 2006
- 5. FCC 3G Review Guidance, Laboratory Division OET FCC, May/June 2006
- Berger, H. S., "Compatibility Between Hearing Aids and Wireless Devices," Electronic Industries Forum, Boston, MA, May, 1997
- 7. Berger, H. S., "Hearing Aid and Cellular Phone Compatibility: Working Toward Solutions," Wireless Telephones and Hearing Aids: New Challenges for Audiology, Gallaudet University, Washington, D.C., May, 1997 (To be reprinted in the American Journal of Audiology).
- 8. Berger, H. S., "Hearing Aid Compatibility with Wireless Communications Devices, "IEEE International Symposium on Electromagnetic Compatibility, Austin, TX, August, 1997.
- 9. Bronaugh, E. L., "Simplifying EMI Immunity (Susceptibility) Tests in TEM Cells," in the 1990 IEEE International Symposium on Electromagnetic Compatibility Symposium Record, Washington, D.C., August 1990, pp. 488-491
- 10. Byme, D. and Dillon, H., The National Acoustics Laboratory (NAL) New Procedure for Selecting the Gain and Frequency Response of a Hearing Aid, Ear and Hearing 7:257-265, 1986.
- Crawford, M. L., "Measurement of Electromagnetic Radiation from Electronic Equipment using TEM Transmission Cells," U.S. Department of Commerce, National Bureau of Standards, NBSIR 73-306, Feb. 1973.
- 12. Crawford, M. L., and Workman, J. L., "Using a TEM Cell for EMC Measurements of Electronic Equipment," U.S. Department of Commerce, National Bureau of Standards. Technical Note 1013, July 1981.
- 13. EHIMA GSM Project, Development phase, Project Report (1st part) Revision A. Technical-Audiological Laboratory and Telecom Denmark, October 1993.
- 14. EHIMA GSM Project, Development phase, Part II Project Report. Technical-Audiological Laboratory and Telecom Denmark, June 1994.
- 15. EHIMA GSM Project Final Report, Hearing Aids and GSM Mobile Telephones: Interference Problems, Methods of Measurement and Levels of Immunity. Technical-Audiological Laboratory and Telecom Denmark, 1995.
- 16. HAMPIS Report, Comparison of Mobile phone electromagnetic near field with an upscaled electromagnetic far field, using hearing aid as reference, 21 October 1999.
- 17. Hearing Aids/GSM, Report from OTWIDAM, Technical-Audiological Laboratory and Telecom Denmark, April 1993.
- 18. IEEE 100, The Authoritative Dictionary of IEEE Standards Terms, Seventh Edition.
- 19. Joyner, K. H, et. al., Interference to Hearing Aids by the New Digital Mobile Telephone System, Global System for Mobile (GSM) Communication Standard, National Acoustic Laboratory, Australian Hearing Series, Sydney 1993.
- Joyner, K. H., et. al., Interference to Hearing Aids by the Digital Mobile Telephone System, Global System for Mobile Communications (GSM), NAL Report #131, National Acoustic Laboratory, Australian Hearing Series, Sydney, 1995.
- 21. Kecker, W. T., Crawford, M. L., and Wilson, W. A., "Contruction of a Transverse Electromagnetic Cell", U.S. Department of Commerce, National Bureau of Standards, Technical Note 1011, Nov. 1978.
- 22. Konigstein, D., and Hansen, D., "A New Family of TEM Cells with enlarged bandwidth and Optimized working Volume," in the Proceedings of the 7th International Symposium on EMC, Zurich, Switzerland, March 1987; 50:9, pp. 127-132.

FCC ID: A3LSMG998U	PCTEST* Proud to be part of @ decreed	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Dogg 20 of 40
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 38 of 42

- 23. Kuk, F., and Hjorstgaard, N. K., "Factors affecting interference from digital cellular telephones," Hearing Journal, 1997; 50:9, pp 32-34.
- 24. Ma, M. A., and Kanda, M., "Electromagnetic Compatibility and Interference Metrology," U.S. Department of Commerce, National Bureau of Standards, Technical Note 1099, July 1986, pp. 17-43.
- 25. Ma, M. A., Sreenivashiah, I., and Chang, D. C., "A Method of Determining the Emission and Susceptibility Levels of Electrically Small Objects Using a TEM Cell," U.S. Department of Commerce, National Bureau of Standards, Technial Note 1040, July 1981.
- 26. McCandless, G. A., and Lyregaard, P. E., Prescription of Gain/Output (POGO) for Hearing Aids, Hearing Instruments 1:16-21, 1983
- 27. Skopec, M., "Hearing Aid Electromagnetic Interference from Digital Wireless Telephones, "IEEE Transactions on Rehabilitation Engineering, vol. 6, no. 2, pp. 235-239, June 1998.
- 28. Technical Report, GSM 05.90, GSM EMC Considerations, European Telecommunications Standards Institute, January 1993.
- 29. Victorian, T. A., "Digital Cellular Telephone Interference and Hearing Aid Compatibility—an Update," Hearing Journal 1998; 51:10, pp. 53-60
- 30. Wong, G. S. K., and Embleton, T. F. W., eds., AIP Handbook of Condenser Microphones: Theory, Calibration and Measurements, AIP Press.

FCC ID: A3LSMG998U	PCTEST* Proud to be pert of the decreased	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename: Test Dates:		DUT Type:		Dogg 20 of 42
1M2012210203-05-R1.A3L	02/08/2021 - 02/12/2021	Portable Handset		Page 39 of 42